

We focus on power.

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TAPERED AMPLIFIER

GaAs Semiconductor Laser Diode







General Product Information

| Product | Application |
|--------------------------|--------------------|
| 850 nm Tapered Amplifier | Raman Spectroscopy |
| C-Mount Package | Cs Spectroscopy |
| | Metrology |
| | |



Absolute Maximum Ratings

| | Symbol | Unit | min | typ | max |
|---------------------------------|------------------|------|-----|-----|-----|
| Storage Temperature | T_S | °C | -40 | | 85 |
| Operational Temperature at Case | T_{C} | °C | 0 | | 50 |
| Forward Current | I _F | Α | | | 3.0 |
| Reverse Voltage | V_R | V | | | 0 |
| Output Power | P_{opt} | W | | | 1.2 |

non condensing

non condensing

Stress in excess of the Absolute Maximum Ratings can cause permanent damage to the device. Operation at the Absolute Maximum Rating for extended periods of time can adversely affect the device realibility and may lead to reduced operational

Recommended Operational Conditions

| | Symbol | Unit | min | typ | max |
|---------------------------------|----------------|------|-----|-----|-----|
| Operational Temperature at Case | T _C | °C | 0 | | 40 |
| Forward Current | I _F | Α | | | 2.8 |
| Input Power | P_{input} | mW | 10 | | 50 |
| Output Power | P_{opt} | W | | | 1.0 |
| | | | | | |

| Measurement Conditions / Comments | |
|---|--|
| non condensing | |
| | |
| | |
| with proper injection from a seed laser | |

Characteristics at T_{LD} = 25 °C at Begin Of Life

| Parameter | Symbol | Unit | min | typ | max |
|---|----------------------|--------|-----|------|-----|
| Center Wavelength | λ_{C} | nm | 840 | 850 | 860 |
| Gain Width (FWHM) | $\Delta\lambda$ | nm | | 20 | |
| Temperature Coefficient of Wavelength | $d\lambda$ / dT | nm / K | | 0.3 | |
| Amplification | P_{opt} | dB | | 13 | |
| Operational Current @ $P_{opt} = 1.0 W$ | I _{op Gain} | А | | | 2.8 |
| Output Power @ I _F = 2.8 A | P _{opt} | W | 1.0 | | |
| Cavity Length | L | μm | | 4000 | |

| Measurement Conditions / Comments |
|---|
| see images on page 4 |
| |
| |
| with wronge injection from a good locar |
| with proper injection from a seed laser |
| |
| |







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| Characteristics at T _{amb} 25 °C at Begin Of Life co | | | cont'd | | | |
|---|--------------------|------|--------|-----|-----|-------------------------|
| Parameter | Symbol | Unit | min | typ | max | Measurement Cond |
| Input Aperture (at rear side) | d _{input} | μm | | 3 | | |
| Output Aperture (at front side) | d_{output} | μm | | 210 | | |
| Astigmatism | А | μm | | 600 | | depending on opera |
| Divergence parallel (FWHM) | $\Theta_{ }$ | 0 | | 15 | | |
| Divergence perpendicular (FWHM) | Θ_{\perp} | 0 | | 28 | | |
| Polarization | | | | TE | | E field parallel to jur |

| Measurement Conditions / Comments |
|------------------------------------|
| |
| depending on operating conditions |
| |
| E field parallel to junction plane |



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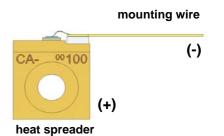
Package Dimensions

| Parameter | Symbol | Unit | min | typ | max |
|--------------------------|--------|------|------|------|------|
| Height of Emission Plane | h | mm | 7.05 | 7.20 | 7.35 |
| C-Mount Thickness | t | mm | | 4.15 | |

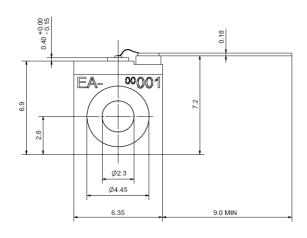
| Measurement Conditions / Comments | |
|-----------------------------------|--|
| | |

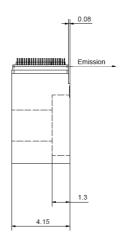
Package Pinout

| Cathode (-) | Mounting Wire |
|-------------|---------------|
| Anode (+) | Housing |
| | |



Package Drawings





Z07-0000-CMT04-BAL-DATA





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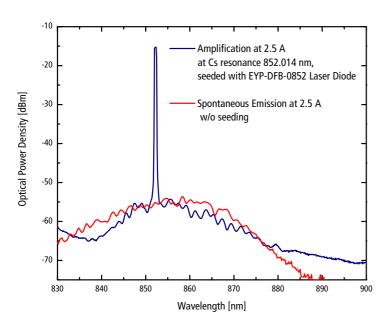
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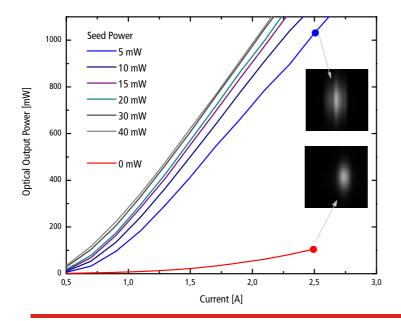


Typical Measurement Results

Spectrum seeded at 852 nm



P-I-Curve seeded at 852 nm



Performance figures, data and any illustrative material provided in this specification are typical and must be specifically confirmed in writing by eagleyard Photonics before they become applicable to any particular order or contract. In accordance with the eagleyard Photonics policy of continuous improvement specifications may change without

Ordering Information:



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Email orders to: sales@xsoptix.com Fax orders to: 800-878-7282





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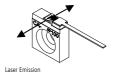
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Unpacking, Installation and Laser Safety

Unpacking the laser diodes should only be done at electrostatic safe workstations (EPA). Though protection against electro static discharge (ESD) is implemented in the laser package, charges may occur at surfaces. Please store this product in its original package at a dry, clean place until final use. During device installation, ESD protection has to be maintained.





The TPA diode type is known to be sensitive against thermal stress. It should not be operated without appropriate injection from a seed laser. Operating at moderate temperatures on propper heat sinks willl contribute to a long lifetime of the diode.

The laser emission from this diode is close to the invisible infrared region of the electromagnetic spectrum. Avoid direct and/or indirect exposure to the free running beam. Collimating the free running beam with optics as common in optical instruments will increase threat to the human eye.











